

12500 TI Boulevard, MS 8640, Dallas, Texas 75243

PCN#20230322001.1 Qualification of new Fab site (RFAB) using qualified Process Technology, Die Revision, and datasheet for select devices

Change Notification / Sample Request

Date: March 23, 2023

To: PREMIER FARNELL PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

Texas Instruments requires acknowledgement of receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If additional data is required, requests must be received within **30** days of this notification.

The changes discussed within this PCN will not take effect any earlier than the proposed first ship date on Page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice or to provide acknowledgement of this PCN, you may contact your local Field Sales Representative or the PCN Team (PCN www admin team@list.ti.com). For sample requests or sample related questions, contact your local Field Sales Representative.

Sincerely,

PCN Team SC Business Services

20230322001.1 Attachment: 1

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE SN74LVC4245ADBR **CUSTOMER PART NUMBER**

null

Technical details of this Product Change follow on the next page(s).

PCN Number: 20230322			2001.1			PCN Date:			March 23, 2023	
Title	:	-			, ,	qualified	Pro	cess	Techn	ology, Die Revision,
			sheet for	selec	ct devices					
Cust	tomer	Contact:		PCN	<u>l Manager</u>		Dep	t:		Quality Services
Proposed 1 st Ship Date:			1 111ng /1 /11/3			e requests ted until:			April 23, 2023*	
*Sa	mple r	equests	received	a fte	r April 23, 2023 w	ill not be	e su	ppo	rted.	
Change Type:										
	Assem	bly Site		Assembly Process			Assembly Materials		nbly Materials	
\boxtimes	Desigr)		\boxtimes				■ Mechanical Specification		anical Specification
	Test S	ite		Packing/Shipping/Labeling					Test I	Process
☐ Wafer Bump Site			☐ Wafer Bump Material					Wafer Bump Process		
□ Wafer Fab Site			₩ Wafer Fab Materials				\boxtimes	Wafer	Fab Process	
				☐ Part number change						
	PCN Details									

Description of Change:

Texas Instruments is pleased to announce the qualification of a new fab & process technology (RFAB, LBC9) for selected devices as listed below in the product affected section. There are no construction differences.

С	urrent Fab Site	•	Additional Fab Site			
Current Fab Process Site		Wafer Diameter	Additional Fab Site	Process	Wafer Diameter	
FR-BIP-1	ASLNONC10	200 mm	RFAB	LBC9	300 mm	

The die was also changed as a result of the process change.

The datasheets will be changing as a result of the above mentioned changes. The datasheet change details can be reviewed in the datasheet revision history shown below. The links to the revised datasheets are available in the table below.

Product Folder	Current Datasheet Number	New Datasheet Number	Link to full datasheet
SN74LVC4245A	SCAS375I	SCAS375J	https://www.ti.com/product/SN74LV C4245A
SN74LVCC3245A	SCAS585P	SCAS585Q	https://www.ti.com/product/SN74LV CC3245A
SN74LVCH8T245	SCES637B	SCES637C	https://www.ti.com/product/ SN74LVCH8T245



SN74LVC4245A

SCAS375J - MARCH 1994 - REVISED DECEMBER 2022

SN74LVC4245A Octal Bus Transceiver and 3.3-V to 5-V Shifter With 3-State Outputs



SN74LVCC3245A Octal Bus Transceiver With Adjustable Output Voltage and 3-State Outputs

CI	hanges from Revision P (December 2015) to Revision Q (December 2022)	Page
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Added thermal information for DB and PW package	6
•	Added inclusive terminology	15



SN74LVCH8T245

SCES637C - AUGUST 2005 - REVISED DECEMBER 2022

SN74LVCH8T245 8-BIT Dual-Supply Bus Transceiver With Configurable Level-Shifting, Voltage Translation, and 3-State Outputs

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (January 2016) to Revision C (December 2022)

Page

Reason for Change:

Supply Continuity

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

Impact on Environmental Ratings

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
☑ No Change		☑ No Change	☑ No Change

Changes to product identification resulting from this PCN:

Fab Site Information:

FR-BIP-1 RFAB	TID RFB	DEU USA	Freising Richardson
ED DID 4	` /	DELL	
Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City

Die Rev:

Current	New				
Die Rev [2P]	Die Rev [2P]				
- B	^				

Sample product shipping label (not actual product label)

TEXAS INSTRUMENTS MADE IN: Malaysia 2DC: 2Q;

MSL 2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04

OPT: ITEM:

(L)T0:1750 LBL:



(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483812

(P) (2P) REV: (V) 0033317 (201) CSO: SHE (211) CCO: USA (22L) ASO: MLA (23L) ACO: MYS

Product Affected:

SN74LVCC3245ADBR	SN74LVC4245ADBR	SN74LVCH8T245PWR

TI Information Selective Disclosure

Qualification Report Approve Date 01-MARCH -2023

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	#	Test Name	Condition	Duration	Qual Device: SN74LVC4245ADBR	Qual Device: SN74LVCC3245ADBR	QBS Reference: SN74HCS74QPWRQ1	QBS Reference: SN74LVC8T245DBR	QBS Reference: <u>TL494IDR</u>	QBS Reference: TPS2074DB
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-	-	-	1/77/0	3/231/0	-
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-		3/231/0	-	-	-
UHAST	АЗ	Autoclave	121C/15psig	96 Hours	-	-	-	1/77/0	-	-
UHAST	АЗ	Autoclave	121C/15psig	96 Hours	-	-	3/231/0	-	-	-
UHAST	АЗ	Unbiased HAST	130C/85%RH	96 Hours	-	-	-	-	-	3/231/0
тс	A4	Temperature Cycle	-65C/150C	500 Cycles	-	-	-	1/77/0	-	3/231/0
тс	A4	Temperature Cycle	-65C/150C	500 Cycles	-	-	3/231/0	-	-	-
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	-	-	-	-	3/231/0
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	-	3/135/0	-	-	-
HTSL	A6	High Temperature Storage Life	170C	420 Hours	-	-	-	1/77/0	-	-

HTOL	B1	Life Test	125C	1000 Hours	-	-	3/231/0	-	-	-
ELFR	B2	Early Life Failure Rate	125C	48 Hours	-	-	3/2400/0	-	-	-
SD	СЗ	PB Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-		1/15/0	-		-
SD	С3	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-		1/15/0	-	-	-
PD	C4	Physical Dimensions	Cpk>1.67	-	-	-	3/30/0	-	-	-
ESD	E2	ESD CDM	-	250 Volts	1/3/0	1/3/0	-	1/3/0	-	-
ESD	E2	ESD CDM	-	500 Volts	-	-	1/3/0	-	-	-
ESD	E2	ESD HBM	-	1000 Volts	1/3/0	1/3/0	-	1/3/0	-	-
ESD	E2	ESD HBM	-	2000 Volts	-	-	1/3/0	-	-	-
LU	E4	Latch-Up	Per JESD78	-	1/3/0	1/3/0	-	1/3/0	-	-
LU	E4	Latch-Up	Per JESD78	-	-	-	1/6/0	-	-	-
CHAR	E5	Electrical Characterization	Per Datasheet Parameters	-	1/30/0	1/30/0	-	1/30/0	-	-
CHAR	E5	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	-	-	3/90/0	-	-	-

- QBS: Qual By Similarity
- Qual Device SN74LVC4245ADBR is qualified at MSL1 260C
- Qual Device SN74LVCC3245ADBR is qualified at MSL1 260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

TI Qualification ID: R-CHG-2211-069

Qualification Report Approve Date 01-MARCH -2023

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	#	Test Name	Condition	Duration	Qual Device: SN74LVCH8T245PWR	QBS Reference: SN74HCS74QPWRQ1	QBS Reference: SN74AXC8T245QPWRQ1	QBS Reference: SN74LXC8T245QPWRQ1
HAST	A2	Biased HAST	130C/85%RH	96 Hours	2	3/231/0	3/231/0	-
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-	-		1/77/0
UHAST	А3	Autoclave	121C/15psig	96 Hours	5 78	-	3/231/0	1/77/0
UHAST	АЗ	Autoclave	121C/15psig	96 Hours	-	3/231/0	-	-
UHAST	A3	Autoclave	130C/85%RH	96 Hours	-	-	3/231/0	1/77/0
TC	A4	Temperature Cycle	-65C/150C	500 Cycles		3/231/0	3/231/0	-
TC	A4	Temperature Cycle	-65C/150C	500 Cycles	-	-	-	1/77/0
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	3/135/0	3/135/0	-
HTSL	A6	High Temperature Storage Life	175C	500 Hours	÷	-	٠	1/45/0
HTOL	B1	Life Test	125C	1000 Hours	-,	3/231/0	3/231/0	1/77/0
ELFR	B2	Early Life Failure Rate	125C	48 Hours		3/2400/0	,-	-
SD	C3	PB Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	1/15/0	-	
SD	C3	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	1/15/0	-	-
PD	C4	Physical Dimensions	Cpk>1.67	-	-	3/30/0		1/10/0
ESD	E2	ESD CDM	-	2000 Volts	-	-		1/3/0
ESD	E2	ESD CDM	-	250 Volts	1/3/0	-		-
ESD	E2	ESD CDM	-	500 Volts	-	1/3/0	-	-
ESD	E2	ESD HBM	-	1000 Volts	1/3/0	-	-	-
ESD	E2	ESD HBM	-	2000 Volts	-	1/3/0	-	-
ESD	E2	ESD HBM	-	4500 Volts	-	-		1/3/0
LU	E4	Latch-Up	Per JESD78	-	1/3/0	-	-	-
LU	E4	Latch-Up	Per JESD78	-	-	1/6/0	1/6/0	1/6/0
CHAR	E5	Electrical Characterization	Per Datasheet Parameters	-	1/30/0	-	-	-
CHAR	E5	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	-	3/90/0	3/90/0	3/90/0

- QBS: Qual By Similarity
- Qual Device SN74LVCH8T245PWR is qualified at MSL1 260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

• The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Ph-free Status

Qualified Pb-Free(SMT) and Green

TI Qualification ID: R-CHG-2211-068

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail				
WW Change Management Team	PCN www admin team@list.ti.com				

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